

Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/804,084	TAKADA ET AL.
	Examiner	Art Unit
	Mark A. Chapman	1756

SEARCHED

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
430	111.4	5/14/2006	MC
	109.1		
	109.4		
137.15,137.17			